

<b>Notice of References Cited</b>		Application/Control No. 09/437,580	Applicant(s)/Patent Under Reexamination MACINNIS ET AL.	
		Examiner Kevin M. Nguyen	Art Unit 2674	Page 1 of 1

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	C	US-			
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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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EXAMINER	DATE	
Kee M. Tung	June 23, 2000	Form892ccs2106b

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(See Manual of Patent Examining Procedure, section 707.05(a).)